

Dirt Spot Sweeping Random Strategy

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Abstract—This paper presents an enhanced and improved form of automated random testing, called Dirt Spot Sweeping Random (DSSR) strategy. DSSR strategy is a new strategy that combines ordinary random strategy and random plus strategy to achieve their combined benefits and additionally sweeps the dirt spots (Faulty patterns) in the program code for faults. It is based on two intuitions, first is that test values in boundaries of equivalence partition are interesting, using these test values in isolation can detect new faults in the system with fewer number of test executions, which produce high impact on test results while second is that faults reside in block and strip patterns inside the input domain therefore when a fault is found, using neighbouring values of the fault finding value can reveal more faults quickly which consequently increases the test performance.

I. INTRODUCTION

Success of software testing is based mainly on the number of faults it discovers in the Software Under Test (SUT). An efficient testing process would discover maximum number of faults in minimum possible time. Exhaustive testing where software is tested against all possible inputs is not feasible in most cases because of large number of inputs, limited resources and strict time constraints. Therefore, strategies in automated software testing tools are developed with the aim to select more fault-finding test input from the input domain for the given SUT. However, it is difficult to produce such targeted test input because each system has its own requirements and functionality.

Chan et al. [6] discovered that there are patterns of failure causing inputs across the input domain. They divided the patterns into point, block and strip patterns on the basis of their occurrence across the input domain.

In another study, Chen et al. [1] found that the performance of random testing can be increased by slightly altering the technique of test case selection. In adaptive random testing, they found that the performance of random testing increases by up to 50% when test input is selected evenly across the whole input domain. This was mainly attributed to the better distribution of input which increased the chance of selecting inputs from failure patterns. Similarly Restricted Random Testing [2], Feedback directed Random Test Generation [3], Mirror Adaptive Random Testing [4] and Quasi Random Testing [5] also stress on the need of test case selection covering the whole input domain to get better results.

Motivated by research work underlying Proportional Sampling Strategy of the patterns of failure causing inputs across the input domain, we thought an enhanced random testing technique called Dirt Spot Sweeping Random (DSSR) strategy. The main emphasis in DSSR strategy is focused on the patterns of failures for better performance. Experiments were conducted to address the following research issues:

- 1) To get highly efficient algorithm for coping with the combination of strategies including pure random, random plus and spot sweeping.
- 2) To get high number of unique faults in the SUT.
- 3) To get lower number of unique faults and higher number of similar faults in the SUT.
- 4) To examine no/negative improvement in test results of the SUT.
- 5) To determine the processing time involved in DSSR strategy.

The rest of this paper is organized in the following sections: Section, II to X; describe DSSR strategy, Implementation of the strategy, Experimental setup and analysis, evaluation of the strategy, Experimental results, Unique faults found by the strategy, discussion, conclusion and future work respectively.

II. DIRT SPOT SWEEPING RANDOM STRATEGY

Dirt Spot Sweeping Random (DSSR) strategy is developed during the present study. It is a combination of the two existing strategies (Random and Random plus) with the addition of one new strategy called Spot sweeping. The strategy is based on two intuitions. One is that boundaries have interesting values and using these values in isolation can provide high impact on test results, the other is that faults can reside in block and strip pattern thus using neighbouring values of the fault finding value can lead us to the next fault in the same block or strip. This increases the performance of the test strategy in terms of executing fewer numbers of test cases with higher number of faults. Each component is briefly explained as follows.

A. Random Testing Strategy

Random testing (hereafter referred to as Pure Random Testing) is a black-box testing technique in which the SUT is executed against randomly selected test data. Test results obtained are compared against the defined oracle, using SUT specifications in the form of contracts or assertions. In the absence of contracts and assertions the exceptions defined by the

programming language are used as test oracle. According to Beizer [7], software performance is directly dependent on the combination of two main factors, correctness and robustness. Correctness is the expected behaviour of the software based on its specifications while robustness is the behaviour of the software that is not defined in its specifications. Since random testing generates test data randomly, without any specific pattern, therefore it effectively tests the performance of software by evaluating it for both correctness and robustness. This strategy, because of its black-box testing nature, is particularly effective in testing softwares where the developers want to keep the source code secret [8]. The generation of random test data is comparatively cheap and does not require too much intellectual and computation efforts [9], [10]. It is mainly for this reason that various researchers have recommended this strategy for incorporation in automatic testing tools [11]. YETI [12], [13], AutoTest [14], [15], QuickCheck [16], Randoop [17], JArtage [18] are some of the most common automated testing tools based on random strategy.

Efficiency of random testing was made suspicious with the intuitive statement of Myers [19] who termed random testing as one of the poorest methods for software testing. However, experiments performed by various researchers, [15], [20], [21], [22] and [23] have experimentally proved that random testing is simple to implement, cost effective, highly efficient and free from human bias as compared to its rival techniques.

B. Random Plus Strategy

Random plus strategy [14] is an extension of the pure random strategy. It uses some special pre-defined values which can be simple border values or values that have high tendency of finding faults in the SUT. Boundary values [7] are the values on the start and end of a particular type. For instance, if input for a SUT is days of an year which is expressed in numbers from 1 to 365 then -3, -2, -1, 0, 1, 2, 3, 362, 363, 364, 365, 366, 367, 368 can be considered as border values as shown in Figure 1.

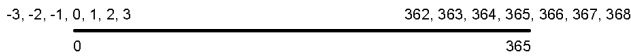


Fig. 1. Boundary values for input domain from 1 to 365

Similarly the tester might also add some other special values that he considers effective in finding faults for the current SUT. For example, if a program under test has a loop from -50 to 50 then the tester can add -55 to -45, -5 to 5, 45 to 55 etc. to the pre-defined list of special values in order to be selected for a test. This static list of interesting values is manually updated before the start of the test and has slightly high priority than selection of random values because of its more relevance and high chances of finding faults for the given SUT. It is reported that these special values have high impact

on the results particularly detecting problems in specifications [10].

C. Dirt Spot Sweeping

Chan et al. [6] found that there are patterns of failure-causing inputs across the input domain. Figure 2 shows these patterns for two dimensional input domain. They divided these patterns into three types called points, block and strip patterns. Black area (Points, block and strip) inside the box show the input which causes the system to fail while white area inside the box represent the genuine input. Boundary of the box (black solid line) surrounds the complete input domain and also represents the boundary values. They also argued that a strategy get more chances of hitting these fault patterns if test cases far away from each other are selected. Other researchers, [2], [4] and [5], also tried to generate test cases further away from one another targeting these patterns and achieved higher performance.

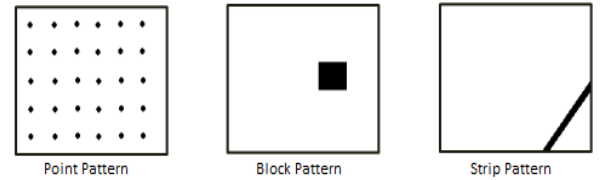


Fig. 2. Failure patterns across input domain [1]

Spot sweeping is the part of DSSR strategy that comes in to action when a fault is found in the system. On finding fault, it immediately adds the value causing the fault and its neighbouring values to the already existing list of interesting values. For example in a program if int type value 50 causes a fault in the system then spot sweeping will add values from 47 to 53 to the list of interesting values. Now if the fault lies in the block or strip pattern then adding its neighbours will explore all the faults present in that block or strip. As against random plus where the list of interesting values remain static, the list of interesting values is dynamic and changes during the test execution of each program in DSSR strategy.

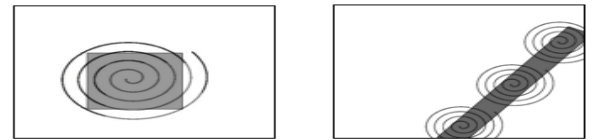


Fig. 3. DSSR covering block and strip pattern

Figure 3 shows how spot sweeping explores the faults residing in the block and strip patterns of a program. The faults coverage from the pattern is shown in spiral form because first fault will lead to second, second to third and so on till the end. In case the fault is positioned on the point pattern then the added values will not be very effective because point pattern is only an arbitrary fault point in the whole input domain.

D. Structure of Dirt Spot Sweeping Random Strategy

The DSSR strategy is explained with the help of flow-chart in Figure 4. In this process the strategy continuously track the number of faults during the execution of the test session. To keep the system fast this tracking is done in a very effective way with zero or minimum overhead [24]. Execution of test is performed normally until a fault is found in the SUT. Then the program not only copy the value that lead to the fault, but also copy its surrounding values to the variable list of interesting values. It is evident from the flow-chart that if the fault finding value is of primitive type then the DSSR finds the type of the value and add values only of that particular type to the interesting values. Addition of these values increases the size of the list of interesting values that provide relevant test data for the remaining test session and the new generated test cases are more targeted towards finding new faults in the given SUT.

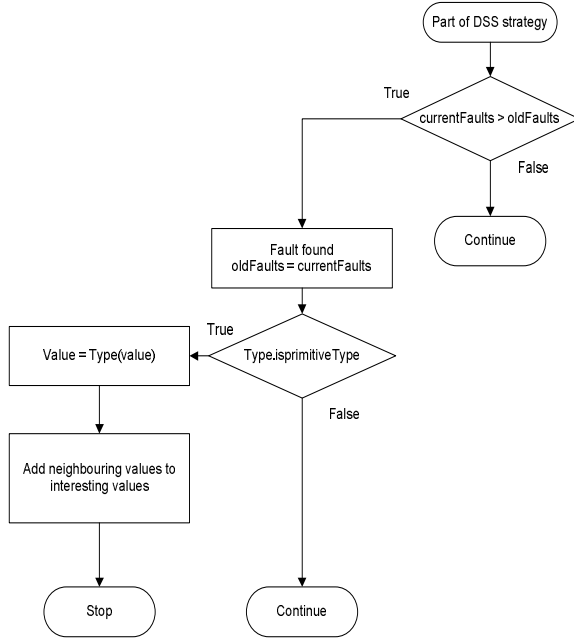


Fig. 4. Working mechanism of DSSR Strategy

Border values and other special values that have high tendency of finding faults in the SUT are added to the list by random plus strategy prior to the start of test session where as to sweep the failure pattern, fault-finding value and its surrounding values are added at run time after a fault is found. Table I contain the values that are added to the list of interesting values when a fault is found. In the table test value is represented by X where X can be int, double, float, long, byte, short, char and String. All values are converted to their respective types before adding to the list of interesting values and vice versa.

Type	Values to be added
X is int, double, float, long, byte, short & char	X, X+1, X-1
X is String	X X + " " " " + X X.toUpperCase() X.toLowerCase() X.trim() X.substring(2) X.substring(1, X.length()-1)

TABLE I: Neighbouring values for primitive types and String

E. Explanation of DSSR with an example program

We explain the concept of DSSR through a simple program. The program is seeded with at least three faults. The first is division by zero exception denoted by 1 and others are in the form of assertion statements denoted by 2 and 3 in the following program. Below we describe how DSSR strategy will perform execution when the following class is expose to testing.

```

/**
 * Calculate square of given number and verify results.
 * Code contain 3 faults.
 * @author (Mian and Manuel)
 * @version (1.1, 11/07/12)
 */

public class Math1 {
    public void calc (int num1) {

        // Square num1 and store result.
        int result1 = num1 * num1;

        int result2 = result1 / num1;..... Fault 1

        assert Math.sqrt(result1) == num1;..... Fault 2

        assert result1 >= num1;..... Fault 3
    }
}
  
```

In the above code one primitive variable of type “int” is used, therefore, the input domain for DSSR is from -2,147,483,648 to 2,147,483,647. DSSR further select some values like 0, Integer.MIN_VALUE and Integer.MAX_VALUE as interesting values and increase its priority for selection as test values. When test start all 3 faults are quickly discovered by DSSR strategy in the following order.

Fault 1: The DSSR strategy might select value 0 for variable “num1” in the first test case because 0 is available in the list of interesting values and therefore its priority for selection is higher than other values. This will cause Java to generate division by zero exception because any integer divided by zero is infinity.

Fault 2: When DSSR strategy catch the first fault, it adds the fault generated and its surrounding values to the list of interesting values which includes 0, 1, 2, 3 and -1, -2, -3 in this case. For second test case DSSR strategy may pick -3 as a test value and it will lead us to the second fault where

assertion (2) will fail because the square root of 9 will be +3 instead of the original value -3.

Fault 3: Few tests later DSSR strategy may select Integer.MAX_VALUE for variable “num1” which is also available in the list of interesting values and it will lead us to the 3rd fault because result1 will not be able to store the square of Integer.MAX_VALUE. Instead of the actual calculated square value Java will assign a negative value (Java language rule) to variable result1 that will again lead to the violation of next assertion (3).

From the above execution process we can understand that, in this example, pre-defined values including border values, fault-finding values and its surrounding values lead us quickly to the available faults and in less number of tests as compared to Random and Random plus strategy which takes longer to discover the same faults because they try to find faults randomly even when the first fault found is very close to the second.

III. IMPLEMENTATION OF DSSR STRATEGY

Instead of reinventing the wheel the DSSR strategy is implemented in an existing open-source automated random testing tool called YETI [25], [26]. YETI tool is developed in Java, which is capable of testing systems developed in procedural, functional and object-oriented languages. Its language-agnostic meta model enables it to test programs written in multiple languages including Java, C#, JML and .Net. The core features of YETI includes easy extensibility for future growth, speed of up to one million calls per minute on java code, real time logging, real time GUI support, ability to test programs using multiple strategies and auto generation of test report at the end of the test session. A number of hitherto faults have successfully been found by YETI in various production softwares.

YETI can be divided into three main sections including core infrastructure, language-specific bindings and strategies. The core infrastructure represents routines, a group of types and a pool of specific type objects. The language specific bindings contain the code to make the call and process the results. The strategies section defines the way to select the class/module to test random selection of routine/method from the given module and get instances of the required type during testing. Most common strategies in this section are random, random plus, DSSR strategy is also added to the strategies section of YETI tool with the class name YetiDSSRStrategy. It is extension of YetiRandomStrategy, which in itself is extension of an abstract class YetiStrategy. The class hierarchy is shown in Figure 5.

If no particular strategy is defined during test initialization then YETI will use its default random plus strategy in which the user can control the probability of null values and the percentage of newly created objects. Both probabilities are set to 10% by default.

YETI also provides an interactive Graphical User Interface (GUI) where a user can see the progress of the current test in real time. Besides GUI, YETI also provides extensive logs of

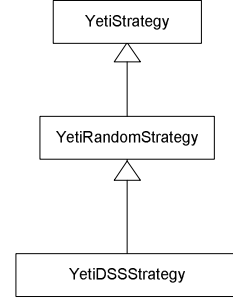


Fig. 5. Class Hierarchy of DSSR in YETI

the test session, which are very helpful in fault tracking. For more details about YETI see references [12] and [13].

IV. EVALUATION

A. Use of Qualitas Corpus for Evaluation

To evaluate the performance of DSSR strategy we performed extensive testing of programs that cover full set of Java applications. Qualitas corpus [27] is a curated collection of such open source java projects built with the aim to help testers in empirical research. These projects are collected in an organized form containing both the source and binary form. The reason for including source code is that most of the binaries do not include infrastructure code like code for demonstrating aspects of the system, testing, installation and building or management tasks. In its latest version 20101126, it contains 106 open source java projects. It is available in two distributions. The release version “r” and the evolution version “e”. The release version is compact size that contain only the recent version of the projects while the evolution version is more detailed which consists of more than 10 different versions of each project.

B. Evaluation by comparison under identical conditions

To get a clear view of DSSR performance we determined the comparative performance of DSSR strategy with pure random strategy and random plus strategy by applying them to similar systems under identical conditions. Both the general factors like system software, hardware and YETI specific factors like percentage of null values, percentage of newly created objects and Interesting value injection probability were kept constant for each test strategy. For all our experiments where applicable the interesting value injection probability was set to 0.5, which means that 50% of the test values will be selected from the list of interesting values while remaining 50% of the values will be selected randomly.

C. Minimizing the effect of Randomness

Random testing is probably the only strategy whose only input is random but its output is also random. It is not necessary that all the faults it found in one test run can also be found in the second test run. Therefore the performance of random strategy cannot be evaluated from a few test sessions. To avoid the random behaviour of random testing every class was tested at least 30 times each by pure random, random plus and DSSR strategy. This is achieved by creating a batch executable script with the handy feature of YETI called compact report that logs each test report to a file for later evaluation.

D. Performance measurement criteria

Various measures including F-measure, P-measure and E-measure have been used by researchers to find the effectiveness of the random test strategy. E-measure (Expected number of failures detected) and P-measure (Probability of detecting at least one failure) received criticism from researchers [1] and are not considered effective techniques for measuring efficiency of test strategy. F-measure (Number of test cases used to find the first fault) used by researchers [28], [29] is quite well known and initially we used it in our experiments to calculate the efficiency. After a few experiments we came to know that this was not the right choice because in some experiments the first strategy found first fault quickly than the second strategy but after the complete test session the first strategy found lower number of total faults than the second strategy. In our view it is not fair to prefer a strategy only because it found the first fault better without giving due consideration to the total number of faults. Moreover, for random testing F-measure is quite unpredictable because its value can be easily increased by adding more narrow conditional statements in the SUT. For example in the following program it is difficult for random testing to generate the exact number (3.3338) quickly and therefore the F-measure will be high.

```
{
    if ( (value > 3.3337) && (value < 3.3339) )
    { 10/0 }
}
```

From the literature we also found that F-measure is used where testing stops after identification of first fault and the system is given back to the developers to remove the found bug where it make though not for random testing but since now automated random testing tests the whole system and print all of the faults found therefore F-measure is not the favourable choice. Therefore in all our experiments performance of the strategy was measured in terms of finding maximum number of faults in a particular number of test calls [15], [3], [30] which in our case was set to 10,000 calls per class. This measurement was found effective because it clearly measured the performance of the strategy when all the other factors were kept constant.

E. Experiments

Extensive experiments were carried out to evaluate the performance of DSSR strategy. Every class was tested 30 times by random, random plus and DSSR strategy. The total number of experiments performed is $100 \times 30 \times 30 \times 30 = 9000$. Each class was evaluated by 1 lac test cases in each experiment so The total number of test cases in 9000 experiments are $9000 \times 1000000 = 9000000000$. The automated oracle used for all experiments was the defined exception of the language because of the absence of the contracts and assertions in the code under test.

Commands for executing the experiments using pure random, random plus and DSSR strategies are as follows. Here Prog1 is the name of the class and nTests is the number of tests set to be executed during this experiment.

- java yeti.Yeti -java -testModules=Prog1 -nTests=10000 -nologs -gui -random.
- java yeti.Yeti -java -testModules=Prog1 -nTests=10000 -nologs -gui -randomPlus.
- java yeti.Yeti -java -testModules=Prog1 -nTests=10000 -nologs -gui -DSSR.

All tests were performed using 64-bit Mac OS X Version 10.7.4 running on Intel(R) Core(TM)2 Duo CPU E8400 @ 3.00GHz with 6.00 GB RAM. Furthermore, Java(SE) Runtime Environment [Version 6.1.7601] was used. It took 4 days (96 hours) for this machine to process all the experiments.

V. RESULTS

Experimental finding indicate that in XX% experiments DSSR strategy performs better than pure random and random plus strategy, in YY% experiment pure random performs better, in ZZ% experiments DSSR and random plus are equivalent and in XYZ% random plus performs better.

No of Experiments	49
Mean	12.32
Median	5
Standard Deviation	17.73
Min No of Faults	0
Max No of Faults	68

TABLE II: 49 Experiments where each strategy performed equally better

	RP = DSSR	PR
Mean	11	10.06
Median	11	11
Standard Deviation	0	2.42
Min No of Faults	11	4
Max No of Faults	11	11

TABLE III: 1 out of 80 Experiments where Pure random and DSSR performed equally better

	PR	DSSR	RP
Mean	16.78	16.65	16.6
Median	17	17	17
Standard Deviation	8.91	8.95	9.03
Min No of Faults	1	1	1
Max No of Faults	17	17	17

TABLE IV: 11 out of 80 Experiments where Pure Random (PR) strategy performed better than DSSR and Random Plus.

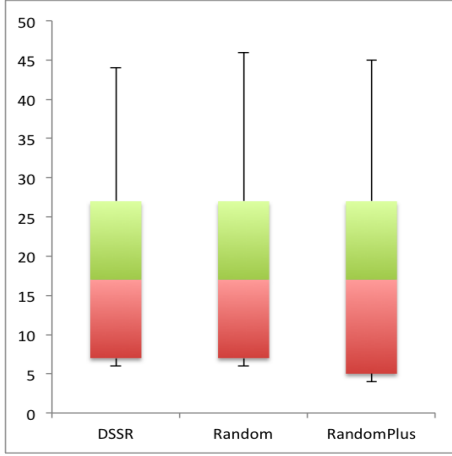


Fig. 6. Pure Random showing better results.

	PR	DSSR	RP
Mean	26.32	26.68	26.95
Median	7	7.5	8
Standard Deviation	31.39	31.02	31.15
Min No of Faults	1	2	1
Max No of Faults	83	83	83

TABLE VI: 7 out of 80 Experiments where Random Plus strategy performed better than Pure Random and DSSR

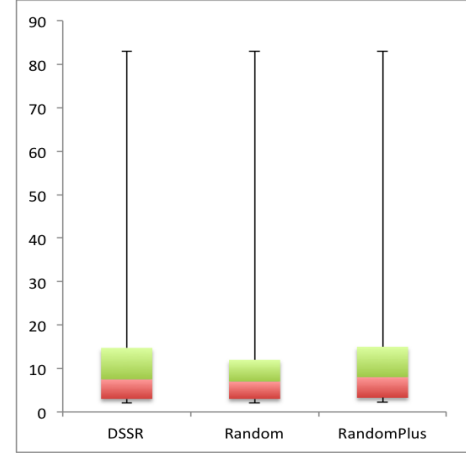


Fig. 8. Random plus showing better results.

	PR	DSSR	RP
Mean	23.44	26.36	26.32
Median	12	12	12
Standard Deviation	15.81	14.70	14.85
Min No of Faults	0	4	4
Max No of Faults	45	45	46

TABLE V: 7 out of 80 Experiments where DSSR strategy performed better than Pure Random and Random Plus

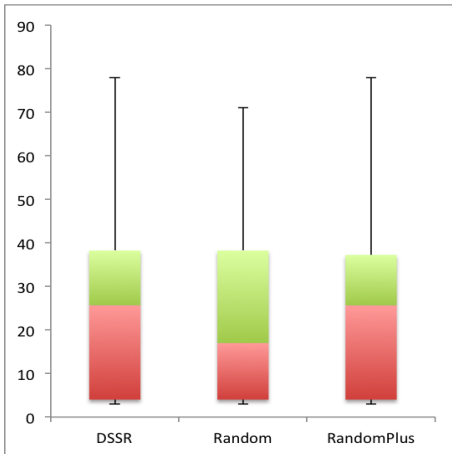


Fig. 7. DSSR showing better results.

	RP = DSSR	PR
Mean	13.76	11.18
Median	7	5
Standard Deviation	15.22	11.60
Min No of Faults	3	0
Max No of Faults	40	31

TABLE VII: 4 out of 80 Experiments where Random Plus and DSSR performed equally better

Note mian (write that there was no case Pure Random is equal to Random Plus.

From the table ?? we can see that in 49 out of 80 experiments all three strategies found equal number of faults. Which means that each strategy is capable enough to find all the faults in one lac test calls. In 11 out of remaining 31 classes Pure Random found highest number of faults. In 7 experiments DSSR found the highest number of faults while in same number of cases Random Plus performed better than DSSR and Pure Random. In 5 experiments both DSSR and Random Plus performed equally well while in only 1 experiment PR and DSSR performed better than Random Plus. Table VIII include names of all the faults that DSSR strategy found in respective classes. Duplicate faults were removed for simplicity.

Class Name	Unique Fault Name
java.lang.ProcessBuilder	NullPointerException YetiSecurityException ArrayIndexOutOfBoundsException
java.lang.ClassLoader	NoClassDefFoundError IndexOutOfBoundsException
java.lang.Character	StringIndexOutOfBoundsException ArrayIndexOutOfBoundsException IllegalArgumentException
java.util.Scanner	IllegalArgumentException NoSuchElementException PatternSyntaxException IllegalStateException StringIndexOutOfBoundsException InputMismatchException UnsupportedOperationException
java.util.Properties	NullPointerException ClassCastException
java.util.Calendar	ArrayIndexOutOfBoundsException IllegalArgumentException
java.lang.Double	NullPointerException
java.lang.Thread	IllegalArgumentException IllegalThreadStateException NoSuchMethodError
java.lang.String	PatternSyntaxException IndexOutOfBoundsException StringIndexOutOfBoundsException
java.lang.Collections	ClassCasteException IndexOutOfBoundsException UnsupportedOperationException IllegalArgumentException OutOfMemoryError

TABLE VIII: Unique faults found by DSS in respective class

Performance of DSSR strategy, Random strategy and Random plus strategy in terms of finding faults: Analysis of results revealed that DSSR performs better than random and random plus in programs with block and strip pattern of faults. However, since not all the programs contain faults in the form of block and strip patterns therefore the results do not show a significant performance change.

Time taken by DSSR strategy, Random strategy and Random plus strategy to execute tests: To execute equal number of test cases, DSSR strategy took slightly more execution time than pure random and random plus test strategy. It is not unusual and we were expecting similar behaviour because pure random algorithm selects random input of the required type with minimum calculation and therefore its process is very quick. On the other hand random plus and DSSR strategy performs additional computation when it maintains the list of interesting values and selects the correct type test values from the list when required. The desired process of adding values to the list and selecting the required values from the list consumes extra time which is the main reason that DSSR strategy takes a little extra time. Thus in executing tests random strategy, random plus and DSSR strategy comes first, second and third respectively.

Effect of test duration in terms of time and number of tests on test results: We found that test duration increases either because of increase in time or number of test cases which results in improving the performance of DSSR strategy than random and random plus. It is because when test duration or number of tests increases, the list of interesting values also increases and in turn DSSR strategy get enough relevant values in the list of interesting values and can easily pick one from the list instead of selecting it randomly or from static list of random plus.

Effect of number of faults on results: We also found that DSSR strategy performs better when the number of faults are more in the code. The reason is that when a fault is found in the code, DSSR strategy adds the neighbouring values of the fault finding value to the list of interesting values. Doing this increases the list of interesting values and the strategy is provided with more relevant test data resulting in higher chance of finding faults.

Can Pure Random and Random Plus Testing perform better than DSSR strategy: The experimental results indicated that pure random and random plus testing can perform better than DSSR strategy if the SUT contain point pattern of failures rather than block and strip pattern. It is due to the fact that in such cases faults don't lay in the neighbourhood of found fault and adding neighbouring values of the founded fault dont make any impact on performance therefore the extra computational time becomes a liability.

DSSR strategy Dependence on Random and Random Plus Testing: During the experiments we found that if the fault finding value is not in the list of interesting values then the test is dependant on random testing. In that case DSSR

strategy has to wait for random testing to find the first fault and only then DSSR strategy will add its neighbouring values to the list of interesting values.

VII. CONCLUSION

The main goal of the present study was to develop a new random strategy which could find more faults in lower number of test cases and shorter execution time. The experimental findings revealed that DSSR strategy was up to 20% more effective in finding faults as compared to random strategy and up to 10 % more effective than random plus strategy. The DSSR strategy not only gave more consistent results but it proved more effective in terms of detecting faults as compared to random and random plus testing.

Improvement in performance of DSSR strategy over random strategy was achieved by taking advantage of Random Plus and fault neighbouring values. Random plus incorporated not only border values but it also added values having higher chances of finding faults in the SUT to the list of interesting values.

The DSSR strategy is highly effective in case of systems containing block and strip pattern of failure across the input domain.

Due to the additional steps of scanning the list of interesting values for better test values and addition of fault finding test value and its neighbour values, the DSSR strategy takes up to 5% more time to execute equal number of test cases than pure random and random plus.

In the current version of DSSR strategy, it might depend on random or random plus strategy for finding the first fault if the fault test value was not in the list of interesting values. Once the first fault is found only then DSSR strategy could make an impact on the performance of test strategy.

The limitation of random plus strategy is that it maintains a static list of interesting values which remains the same for each program under test, and can be effective in many cases but not always. The better approach will be to have a dynamic list of interesting values that is automatically updated for every program which can be achieved by adding the program literals and its surrounding values to the list of interesting values prior to starting every new test session.

VIII. FUTURE WORK

From the research we came to know that random testing is not very good in generating a test value when the scope of a variable is too narrow as in the following example.

```
{
  if(value == 34.4445)
  { 10/0 }
}
```

We also know that if the fault finding value is not in the list than DSSR has to wait for random testing to generate the fault finding value and only after that DSSR strategy will add that value and its surrounding values to the list of interesting values. To decrease the dependancy of DSSR strategy on random and random plus strategy, further work is in progress to add constant literals from the SUT to the list of

interesting values in a dynamic fashion. These literals can be obtained either from .java or .class files of the SUT. We are also working to add neighbouring values of the literals to the list of interesting values.

Thus if we have the above example then the value 34.4445 and its surrounding values will be added to the list of interesting values before the test starts and DSSR strategy will no more be dependent on random testing to find the first fault. Finally, it will also be interesting to evaluate the DSSR strategy in terms of coverage because the newly added values are most suitable for test cases and therefore can increase branch coverage.

IX. ACKNOWLEDGMENT

The author would like to acknowledge with thanks the Department of Computer Science, University of York for the financial support extended as Departmental Overseas Research Scholarship (DORS) which enabled him to continue higher studies leading to PhD. We extend our sincere thanks and appreciation to Prof. Richard Page, Head of the Enterprise System's group of the Department of Computer Science for his valuable help and generous support.

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